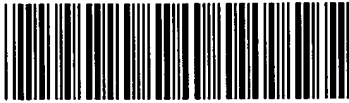


**Search Notes**

Application/Control No.

10/506,490

Examiner

David Buttner

Applicant(s)/Patent under  
Reexamination

FUKASAWA ET AL.

Art Unit

1712

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
428	all	2/22/2007	DB
525	all	2/22/2007	DB
156	all	2/22/2007	DB

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor search	2/22/2007	DB
east	2/22/2007	DB